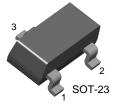
KST42/43



SEMICONDUCTOR®

KST42/43

High Voltage Transistor



1. Base 2. Emitter 3. Collector

NPN Epitaxial Silicon Transistor

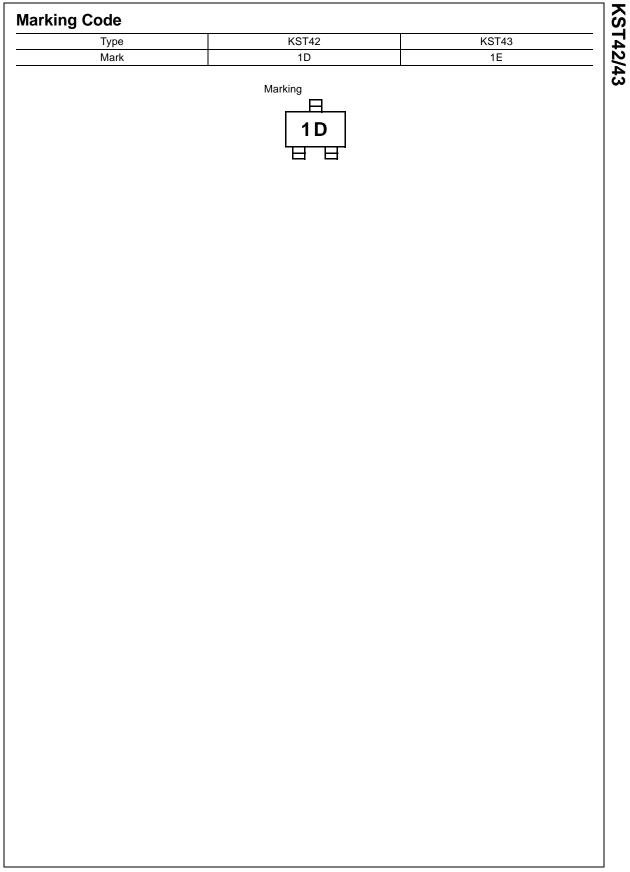
Absolute Maximum Ratings Ta=25°C unless otherwise noted

Symbol	Parameter	Value	Units
V _{CBO}	Collector Base Voltage		
	: KST42	300	V
	: KST43	200	V
V _{CEO}	Collector-Emitter Voltage		
	: KST42	300	V
	: KST43	200	V
V _{EBO}	Emitter-Base Voltage	6	V
I _C	Collector Current	500	mA
P _C	Collector Power Dissipation	350	mW
T _{STG}	Storage Temperature	150	°C
R _{TH} (j-a)	Thermal Resistance junction to Ambient	357	°C/W

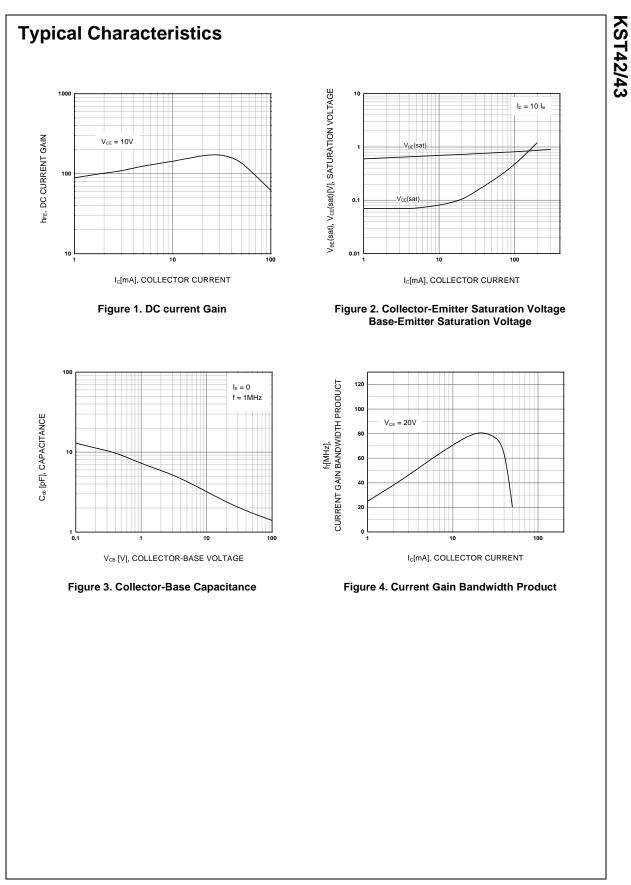
Electrical Characteristics $T_a=25^{\circ}C$ unless otherwise noted

Symbol	Parameter	Test Condition	Min.	Max.	Units
BV _{CBO}	Collector-Emitter Breakdown Voltage : KST42	I _C =100μΑ, I _E =0	300		V
	: KST43		200		V
BV _{CEO}	* Collector -Emitter Breakdown Voltage	I _C =1mA, I _B =0			
	: KST42	-	300		V
	: KST43		200		V
BV _{EBO}	Emitter-Base Breakdown Voltage	I _E =100μA, I _C =0	6		V
I _{CBO}	Collector Cut-off Current	V _{CB} =200V, I _E =0		0.1	μΑ
I _{EBO}	Emitter Cut-off Current	V _{CB} =5V, I _C =0		0.1	μΑ
h _{FE}	* DC Current Gain	V _{CE} =10V, I _C =1mA	25		
		V _{CE} =10V, I _C =10mA	40		
		V _{CE} =10V, I _C =30mA	40		
V _{CE} (sat)	* Collector-Emitter Saturation Voltage	I _C =20mA, I _B =2mA		0.5	V
V _{BE} (sat)	* Base-Emitter Saturation Voltage	I _C =20mA, I _B =2mA		0.9	V
C _{ob}	Output Capacitance				
	: KST42	V _{CB} =20V, I _E =0		3	pF
	: KST43	f=1MHz		4	pF
f _T	Current Gain Bandwidth Product	V _{CE} =20V, I _C =10mA f=100MHz	50		MHz

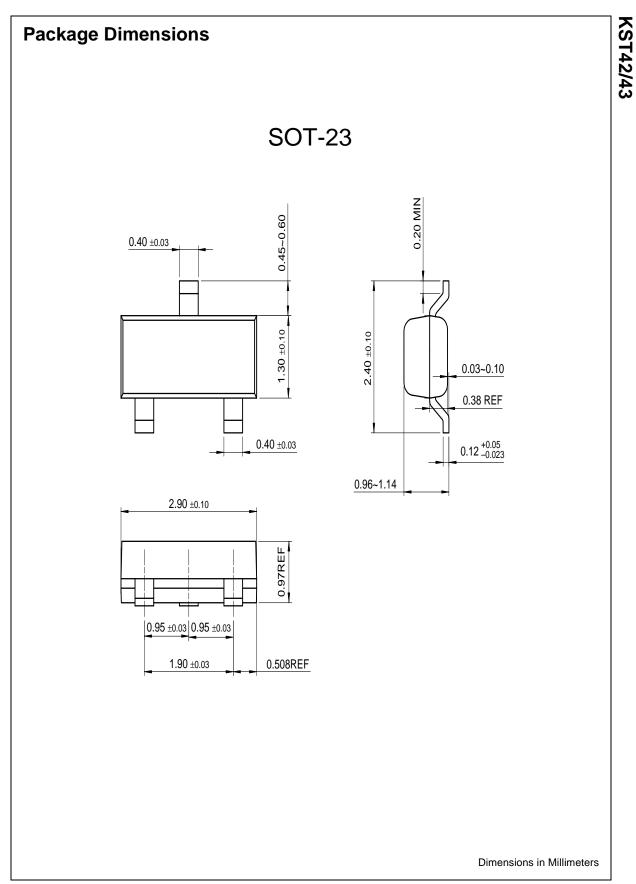
^{*} Pulse Test: PW≤300µs, Duty Cycle≤2%



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2. A critical component is any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.

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Definition of Terms

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No Identification Needed	Full Production	This datasheet contains final specifications. Fairchild Semiconductor reserves the right to make changes at any time without notice in order to improve design.
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